

Search Notes

Application/Control No.

10/829,210

Examiner

Khiem Nguyen

Applicant(s)/Patent under
Reexamination

CHEN, YI-JEN

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	66	9/14/2005	KN
	78		
	81		
	83		
	91		
	247		
	248		
	573		
	591		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR